

Notice of References Cited	Application/Control No. 10/663,794		Applicant(s)/Patent Under Reexamination WEI ET AL.	
	Examiner David Humphrey		Art Unit 1643	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0123622 A1	09-2002	Yu et al.	536/23.5
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO 200196547 A2	12-2001	World Intellect	Yue et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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